

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination YEH ET AL.	
		Examiner Aaron C Perez-Daple	Art Unit 2154	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,131,125 A	10-2000	Rostoker et al.	709/250
	B	US-6,032,203 A	02-2000	Heidhues, Peter Albert	710/11
	C	US-5,729,204	03-1998	Fackler et al.	340/2.4
	D	US-5,875,415 A	02-1999	Lieb et al.	702/122
	E	US-6,334,160 B1	12-2001	Emmert et al.	710/11
	F	US-6,128,673 A	10-2000	Aronson et al.	710/22
	G	US-6,138,180 A	10-2000	Zegelin, Christopher	710/11
	H	US-6,314,479 B1	11-2001	Frederick et al.	710/63
	I	US-5,745,794	04-1998	Poloniewicz et al.	710/62
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.